


<b>Search Notes</b> 	<b>Application/Control No.</b> 10552532	<b>Applicant(s)/Patent Under Reexamination</b> HAYASHI, YASUSHI
	<b>Examiner</b> AMENE S BAYOU	<b>Art Unit</b> 4147

SEARCHED			
Class	Subclass	Date	Examiner
417	415	01/03/08	AB
184	6.18,6.28,7.1	01/03/08	AB

SEARCH NOTES		
Search Notes	Date	Examiner
Talked to SPE George Nguyen about search result and references cited	01/04/08	AB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner